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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
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1622	7590 03/09/2004		EXAM	INER
IRELL & MANELLA LLP			KINDER, DARRELL D	
840 NEWPOR SUITE 400	RT CENTER DRIVE		ART UNIT	PAPER NUMBER
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Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)
Office Action Summary		10/051,987	HONG ET AL.
		Examiner	Art Unit
		Darrell Kinder	2862
Period f	The MAILING DATE of this communication app or Reply	pears on the cover sheet wit	h the correspondence address
THE - Exte afte - If th - If NO - Fail Any	HORTENED STATUTORY PERIOD FOR REPL' MAILING DATE OF THIS COMMUNICATION. ensions of time may be available under the provisions of 37 CFR 1.1 r SIX (6) MONTHS from the mailing date of this communication. e period for reply specified above is less than thirty (30) days, a reply o period for reply is specified above, the maximum statutory period of the property of the	136(a). In no event, however, may a re ly within the statutory minimum of thirty will apply and will expire SIX (6) MONT a, cause the application to become ABA	ply be timely filed (30) days will be considered timely. "HS from the mailing date of this communication. ANDONED (35 U.S.C. § 133).
Status	<u>^</u>		
1)☑ 2a)⊠ 3)□		s action is non-final. nce except for formal matte	
Disposit	tion of Claims		
5)[Claim(s) <u>1'-10</u> is/are pending in the application 4a) Of the above claim(s) is/are withdray Claim(s) is/are allowed. Claim(s) <u>1-10</u> is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction and/o	wn from consideration.	
Applicat	tion Papers		
10)⊠	The specification is objected to by the Examine The drawing(s) filed on 26 January 2003 is/are Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct The oath or declaration is objected to by the Examine	e: a) accepted or b) ob drawing(s) be held in abeyand tion is required if the drawing(s	ce. See 37 CFR 1.85(a). s) is objected to. See 37 CFR 1.121(d).
Priority	under 35 U.S.C. § 119		
a)	Acknowledgment is made of a claim for foreign All b) Some * c) None of: 1. Certified copies of the priority document 2. Certified copies of the priority document 3. Copies of the certified copies of the priority application from the International Bureau See the attached detailed Office action for a list	ts have been received. ts have been received in Apority documents have been in (PCT Rule 17.2(a)).	oplication No received in this National Stage
Attachmei	nt(s)		
1) Noti 2) Noti 3) Info	ce of References Cited (PTO-892) ce of Draftsperson's Patent Drawing Review (PTO-948) rmation Disclosure Statement(s) (PTO-1449 or PTO/SB/08) er No(s)/Mail Date	Paper No(s)	ummary (PTO-413))/Mail Date formal Patent Application (PTO-152)

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DETAILED ACTION

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

The factual inquiries set forth in *Graham* v. *John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:

- 1. Determining the scope and contents of the prior art.
- 2. Ascertaining the differences between the prior art and the claims at issue.
- 3. Resolving the level of ordinary skill in the pertinent art.
- 4. Considering objective evidence present in the application indicating obviousness or nonobviousness.
- 1. Claims 1-3 and 6-8 are rejected under 35 U.S.C. 103(a) as being unpatentable over Zhang et al. "Thermal Decay in High Density Disk Media," <u>IEEE Transactions on Magnetics</u>, vol. 34, no. 5 September 1998 pages 3786-3793 (Zhang), in view of U.S. Patent no. 6,483,300 (Severson) and U.S. Patent no. 6,570,378 (Goh).

Referring to claim 1, Zhang discloses a test stand for testing a thermal decay of a disk of a hard disk drive comprising: a spindle motor that can spin the disk (paragraph 4); a head coupled to the disk (paragraph 4); a controller connected to said head, said controller operates in accordance with a procedure that writes a reference signal onto a reference track (paragraph 7) of the disk, and then reduces an amplitude of the reference signal (paragraph 7), writes a test signal onto the disk (paragraph 7), reads

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the test signal, reads the reference signal, and normalizes the signal with the reference signal (paragraph 10).

Zhang does not disclose that the test stand includes a heating element or that the method and procedure includes a step wherein the disk is heated by a heating element. Zhang does not further disclose that the amplitude of the reference track is actively reduced.

Severson discloses a spin stand, which further includes a disk heater (col. 2 lines 2-3). Severson teaches that the heater is useful in accelerating aging studies on the disk by applying thermal energy to the disk (col. 2 lines 38-45).

One of ordinary skill in the art would have looked to Severson to modify Zhang, as they are analogous art, concerning the testing of disks. Further more one of ordinary skill in the art would have been motivated to modify Zhang with Severson such that the test stand included a heater in order to perform aging and worst-case tests which are accelerated, as Zhang's tests take 15+ hours, and would be benefited by a shorter time span.

Therefore it would have been obvious to one of ordinary skill in the art at the time the invention was made to have modified the stand and method of Zhang such that a heater was used to heat the disk and perform accelerated aging and worst-case tests as it would have accelerated the testing procedure of Zhang, resulting in a more efficient test stand and method.

Furthermore, Goh discloses a method for determining the amplitude decay rate of a magnetic storage medium, wherein a DC erase current is used to actively reduce

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the amplitude of a signal (col. 2 lines 27-58). Goh teaches that the use of the DC erase signal helps to accelerate the test process significantly (col. 1 lines 37-44). A DC erase signal could therefore be used to reduce the amplitude of any signal, reference or test, and provide a more efficient testing means.

One of ordinary skill in the art would have looked to Goh to modify Zhang, or Zhang-Severson, as all are analogous art, concerning magnetic medium testing. Furthermore one of ordinary skill in the art would have been motivated to modify Zhang, or Zhang-Severson with the teachings of Goh, such that a DC erase current was used to actively reduce the amplitude of the reference track signal, as it would further accelerate the aging process, and the testing process, enabling a more efficient, expedited testing process.

2. Referring to claims 2, although the combination of Zhang-Severson does not disclose that the amplitude is reduced with a DC erasing current, Goh teaches the active reduction of the amplitude by use of a DC erase current (col. 2 lines 27-58). Goh teaches that the DC erase current is useful in expediting the amount of time needed to perform a decay test (col. 1 lines 37-44).

One of ordinary skill in the art would have been motivated to use a DC erase current to actively reduce the amplitude, as a DC erase current is old and well known in the art, and also as taught by Goh, useful in expediting amplitude decay tests.

3. Referring to claims 3, the combination of Zhang-Severson-Goh does not explicitly disclose that the amplitude of the test signal is reduced to 60%-80% of peak value.

However this is an arbitrary range, and it is not seen why this range is more beneficial

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than any other range of values that the amplitude could be reduced to. One of ordinary skill in the art could easily have modified the stand and procedure of Zhang-Severson-Goh such that the amplitude was reduced to 60-80% of peak value without undue experimentation as such a range of values may produce results that are more favorable, or easier to analyze, or most accurately characterize the thermal and performance decay of the disk.

Furthermore, the courts have held that no invention is involved in discovering optimum ranges of a process by routine experimentation. *In re Aller*, 220 F.2d 454, 456, 458, 105 USPQ 233, 235 (CCPA 1955). This is unless a claimed range is critical to the invention, showing unexpected results in comparison with any prior art range. *In re Peterson* 315, F.3d 1325, 1330-1331 (Fed. Cir. 2003).

4. Claims 4-5 are rejected under 35 U.S.C. 103(a) as being unpatentable over Zhang-Severson-Goh as applied to claim 1 above, and further in view of U.S. Patent no. 6,483,299 (Pressesky).

Referring to claim 4, the combination of Zhang-Severson-Goh, by way of the teachings of Severson, do not state that the heating portion is a laser that directs a laser beam onto a portion of the disk.

However, a laser beam is old and well known as a thermal source. Furthermore, Pressesky discloses a method and procedure for determining the magnetic properties of magnetic media wherein a thermal source is used, and said thermal source is a laser beam (col. 2 lines 42-56). Pressesky use the laser beam as the thermal source as it

allows for a localized temperature change, only heating a certain portion of the disk (col. 2 lines 30-32).

One of ordinary skill in the art would have looked to Pressesky to modify the combination of Zhang-Severson-Goh, as it is also analogous art: in the art of testing magnetic media (i.e. disks). Furthermore, one of ordinary skill in the art would have been motivated to modify the combination of Zhang-Severson-Goh with the teachings of Pressesky such that the thermal source is a laser, as it would have allowed the localized heating of the disk, so that only the area of the disk containing the reference and/or test tracks could be subjected to heating. This would improve the efficiency of the test by eliminating the unnecessary heating of parts of the disk that are not important to the test.

Therefore it would have been obvious to one of ordinary skill in the art at the time the invention was made to have modified the combination of Zhang-Severson-Goh with the teachings of Pressesky such that the heating element is a laser in order to improve the efficiency of the test.

- 5. Referring to claim 5, the combination of Zhang-Severson-Goh, by way of the thermal source of Severson, discloses a test stand and procedure wherein said head is on a first surface and the heating element, which could be a laser from the teachings of Pressesky above, is directed onto an opposite second surface of the disk (**Fig. 3** heater 200; head 144; disk 106).
- 6. Claims 6-10 are rejected under 35 U.S.C. 103(a) as being unpatentable over Zhang in view of Pressesky and Goh.

Referring to claim 6, Zhang discloses a method for testing a decay of a disk of a hard disk drive comprising: writing a reference signal onto a reference track of the disk (paragraph 7); writing a test signal onto the disk (paragraph 7); reducing an amplitude of the reference signal (paragraph 7); reading the reference signal (paragraph 7); and normalizing the test signal with the reference signal (paragraph 10).

Zhang does not explicitly disclose that the amplitude of the reference signal is actively reduced; letting the disk spin for 15+ hours reduces the amplitude. Zhang also does not disclose that a portion of the disk is heated and that the test signal is read from the heated portion of the disk.

Goh discloses a method for determining the amplitude decay rate of a magnetic storage medium, wherein a DC erase current is used to actively reduce the amplitude of a signal (col. 2 lines 27-58). Goh teaches that the use of the DC erase signal helps to accelerate the test process significantly (col. 1 lines 37-44). A DC erase signal could therefore be used to reduce the amplitude of any signal, reference or test, and provide a more efficient testing means.

One of ordinary skill in the art would have been motivated to modify Zhang, with the teachings of Goh, such that a DC erase current was used to actively reduce the amplitude of the reference track signal, as it would further accelerate the amplitude reduction and the testing process, making it significantly less than 15+ hours, enabling a more efficient, expedited testing process.

Furthermore, Pressesky discloses a method and procedure for determining the magnetic properties of magnetic media wherein a thermal source is used, and said

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thermal source is a laser beam (col. 2 lines 42-56). Pressesky uses the laser beam as the thermal source as it allows for a localized temperature change, only heating a certain portion of the disk (col. 2 lines 30-32). The use of the localized thermal source also effectively lowers the coercivity of the magnetic medium, thus assisting the magnetic transitions, which is the writing process (col. 5 lines 1-2, 25-33).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have further modified the method of Zhang such that a portion of the disk was heated, and that the test signal was read from the heated portion, as it would have provided a means for effectively reducing the coercivity of the disk in a localized area, thus assisting in the transitions of the disk in a localized area, facilitating the writing of a test/reference signal, which can then be read for determining the properties of the magnetic media. The thermal assist allows the method to be performed in a more economical and expedited fashion.

7. Referring to claim 7, Goh teaches the active reduction of the amplitude by use of a DC erase current (col. 2 lines 27-58). Goh teaches that the DC erase current is useful in expediting the amount of time needed to perform a decay test (col. 1 lines 37-44).

One of ordinary skill in the art would have been motivated to use a DC erase current to actively reduce the amplitude, as a DC erase current is old and well known in the art, and also as taught by Goh, useful in expediting amplitude decay tests.

8. Regarding claim 8, the combination of Zhang-Goh-Pressesky does not explicitly disclose that the amplitude of the test signal is reduced to 60%-80% of peak value. However this is an arbitrary range, and it is not seen why this range is more beneficial

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than any other range of values that the amplitude could be reduced to. One of ordinary skill in the art could easily have modified the stand and procedure of Zhang-Goh-Pressesky such that the amplitude was reduced to 60-80% of peak value without undue experimentation as such a range of values may produce results that are more favorable, or easier to analyze, or most accurately characterize the thermal and performance decay of the disk.

Furthermore, the courts have held that no invention is involved in discovering optimum ranges of a process by routine experimentation. *In re Aller*, 220 F.2d 454, 456, 458, 105 USPQ 233, 235 (CCPA 1955). This is unless a claimed range is critical to the invention, showing unexpected results in comparison with any prior art range. *In re Peterson* 315, F.3d 1325, 1330-1331 (Fed. Cir. 2003).

- 9. Referring to claim 9, the combination of Zhang-Goh-Pressesky, by means of the laser source heating assembly of Pressesky discloses a method wherein the disk is heated with a laser beam (col. 5 lines 45-48).
- 10. Claim 10 is rejected under 35 U.S.C. 103(a) as being unpatentable over Zhang-Goh-Pressesky as applied to claim 9 above, and further in view of Severson.

Referring to claim 10, the combination of Zhang-Goh-Pressesky does not explicitly disclose that the method includes reading the test signal with a head located adjacent to a first surface of the disk, and the laser beam (of Pressesky) is directed onto an opposite second surface of the disk.

Severson discloses a test stand and procedure wherein said head is on a first surface and the heating element, is directed onto an opposite second surface of the disk

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(**Fig. 3** heater 200; head 144; disk 106). Severson teaches that heating the opposite surface opposed to the head is advantageous because it reduces heat that is transferred to the spindle (col. 5 lines 3-12).

One of ordinary skill in the art would have bee motivated to modify the combination of Zhang-Goh-Pressesky with the teaching of Severson such that the laser heating source was directed onto an second surface opposite the head in order to reduce heat that is transferred to the spindle of the testing instrument (Zhang paragraph 4), thereby protecting the test device, and furthering the life of the test device and method.

Response to Arguments

11. Applicant's arguments filed 15 December 2003 have been fully considered but they are not persuasive. In response to applicant's argument that the proposed combination uses active reduction via a DC current for accelerating the decay rate, instead of actively reducing to simulate the test amplitude, the fact that applicant has recognized another advantage which would flow naturally from following the suggestion of the prior art cannot be the basis for patentability when the differences would otherwise be obvious. See *Ex parte Obiaya*, 227 USPQ 58, 60 (Bd. Pat. App. & Inter. 1985).

Conclusion

THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Darrell Kinder whose telephone number is 571- 272- 2264. The examiner can normally be reached on Monday-Friday 7:00-4:30, alternate Fridays off.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, N. Le can be reached on 571-272-2233. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

dk

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